

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE PATENT APPLICATION

Appl. No.

10/731,714

Confirmation No. TBD

Applicant

Agashe et al.

Filed:

December 9, 2003

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Examiner

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Docket No.

TI-36268

Customer No.

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Mail Stop Patent Application Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450 CERTIFICATE OF MAILING UNDER 37 CFR 1.8

I hereby certify that the attached document is being deposited with the United States Postal Service with sufficient postage for First Class Mail in an envelope addressed to Commissioner for Patents Alexandria, VA 22313-1450 on:

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INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97 & 1.98

Sir:

Applicants wish to bring to the attention of the Patent and Trademark Office the information noted on the enclosed PTO Form 1449. Pursuant to the new rules, copies of the U.S. Patents herein noted are not enclosed.

Please charge any fees due in connection with the filing of this paper to the deposit account of Texas Instruments Incorporated, Account No. 20-0668. Please credit any excess fees to the same deposit account.

Respectfully submitted,

Texas Instruments Incorporated P. O. Box 655474 MS 3999

Dallas, Texas 75265

(972) 917-5276

April M. Mosby

Attorney for Applicant(s)

Reg. No. 45,955

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO.			SERIAL NO.			
PELIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				TI-36268			10/731,714			
122004	12 2004					APPLICANT: Agashe et al.				
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U.S. PATENT DOCUMENTS *EXAMINER DOCUMENT										
INITIAL	NUMBER	DATE	NAME		CLASS	SUBCLASS		FILING DATE (IF APPROPRIATE)		
	US 6,587,981 B1	07/01/03	Muradali et al.		714	726		11/29/99		
	US 6,442,722 B1	08/27/02	Nadeau-Dostie et al.		714	731		10/29/99		
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 	6,304,988 B1	10/16/01	Levy		714	726		03/17/00		
 										
 										
		 								
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"Scan-Based Transition Fault Testing – Implementation and Low Cost Test Challenges" Saxena et al., ITC International Test Conference, IEEE 2002, pp 1120-1129										
	 									
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EXAMINER				DATE CONS	SIDERED					
*EXAMINER: Initial if a	reference considered, whether or not citation	is in conformance v	with MPEP 609;	Draw line through	citation if not i	n conformanc	e and no	ot considered. Include copy		